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(54) SAMPLE INTRODUCTION INTERFACE FOR ANALYTICAL PROCESSING OF A SAMPLE PLACED ON A SUBSTRATE

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(57) ABSTRACT

An interface system for introducing a non-gaseous sample as a predetermined gaseous form into an analytical instrument which comprises a substrate that receives the non-gaseous sample and a directed energy source that heats at least a portion of said substrate containing the non-gaseous sample to convert the sample to the predetermined gaseous form.

47 Claims, 16 Drawing Sheets

